


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586279	<b>Applicant(s)/Patent Under Reexamination</b>  CASPER ET AL.
	<b>Examiner</b>  M. Lee	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	722, 578-600	10/24/08	ml

SEARCH NOTES		
Search Notes	Date	Examiner
east	10/24/08	ml
application no. 10/586,554 checked, no DP.		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Art Unit 2622
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